

SPECIFICATION SHEET

SPECIFICATION SHEET NO.	Q0626- YG50M00000S420
DATE	Jun. 26, 2023
REVISION	A1
DESCRIPITION	MHz Plastic SMD Crystals, L8.0*W3.8*H2.5mm, 4 Pads, CCMD series
	50.00000MHz, Tolerance +/-20ppm, Load Capacitor 20pF,
	Frequency stability +/-30ppm @Operating Temp. Range -40°C ~+85°C,
	ESR 40 ohm Max, Reflow Profile Condition 260 °C Max.
	Tape/Reel, 3000pcs/Reel
	RoHS/RoHS III compliant, RoHS Annex III lead Exemption (exempt per RoHS
	EU 2015/863)
CUSTOMER	
CUSTOMER PART NUMBER	
CROSS REF. PART NUMBER	
ORIGINAL PART NUMBER	TGS CCMD 50M0A20-20-30-40-40TLH
PART CODE	YG50M00000S420

VENDOR APPROVE

Issued/Checked/Approved

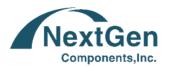






DATE: Jun. 26, 2023

CUSTOMER APPROVE						
DATE:						



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MAIN FEATURE

- SMD Package, 8038 Type, L8.0*W3.8*H2.5mm, 4 Pads
- Low cost and short lead time
- · Industry standard
- Reflow Profile Condition 260 °C Max.
- Cross more competitors part
- RoHS/RoHS III compliant, RoHS Annex III lead Exemption (exempt per RoHS EU 2015/863)

APPLICATION

- Clock source for Portable
- Microcomputer & Automotive Equipment with Low power consumption

PART CODE GUIDE



YG	50M00000 S		420
1	2	3	4

- 1) YG: Part family Code for MHz Plastic SMD Crystals, L8.0*W3.8*H2.5mm, 4 Pads, CCMD series
- 2) 50M00000: Frequency range code for 50.000MHz
- 3) S: SMD type, Package Tape/Reel, 3000pcs/Reel
- 4) 420: Specification code for original part No.: TGS CCMD 50M0A20-20-30-40-40TLH

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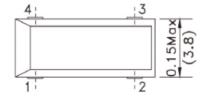
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DIMENSION (Unit: Inch/mm)

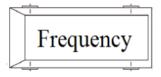
Image for reference



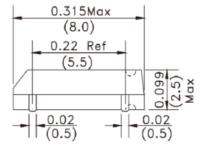
CCMD



Marking Frequency Range



0.035 Ref (0.9)

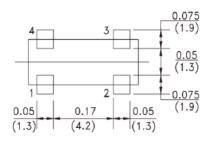


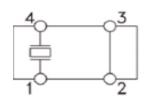
Note:

- Do not connect pad 2 and Pad 3 to external devices.
- Metal inside may be exposed on the top or bottom of plastic case
- It isn't Quality problem. This will not affect any quality, reliability and electrical specification when used

Recommend Pad Layout

NextGen Components, Inc.





Pin Function

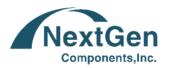
#1 Crystal

#2 Ground

#3 Ground

#4 Crystal

3



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ELECTRICAL PARAMETERS

Paramet	er	Part No. Symbol	Units		Value		
		7,,,,,,,,,		Min.	Typical	Max.	
Original	Manufacturer	TGS		TGS (Crystals		
Holder T	уре	CCMD	MHz SMD Cr	ystal, Plastic	case, L8.0*W3.8	*H2.5mm	
Frequen	cy Range	50M0	MHz		50.000		
Mode of	Oscillation	А			AT Fundamenta	I	
Frequen	cy Tolerance	20	ppm	-20		+20	@25°C
Load Cap	pacitance	-20	pF		20		
Stability Operation	over on Temperance	-30	ppm	-30		+30	
Operation	on Temperance	-40	°C	-40		+85	
Storage	Temperance		°C	-55		+125	
Equivale Resistan	nt Series ce (ESR)	-40	Ω			40	
Drive Le	vel		μW	100		100	
Shunt Ca	pacitance (CO)		pF	0 7.0			
Motiona (C1)	l Capacitance		fF		N/A		
DLD2			Ω		N/A		
FLD2			ppm		N/A		
RDL2			Ω		N/A		
SPDB			dB		N/A		
Aging			ppm/year	±5		±5	@1 st year
Insulatio	n Resistance		ΜΩ	500			@100VDC ± 15VDC
	Package	T		Tape/Reel			
Others	RoHS Status	LH	RoHS III compliant, RoHS Annex III lead Exemption (exempt per RoHS EU 2015/863)				
	Add Value			N	I/A		
	Code		Internal Control: 2 letter or digits or Blank: N/A				

Note: Original Part Number: TGS CCMD 50M0A20-20-30-40-40TLH

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TEST STANDARD

General Electrical Characteristics And Visual testing

1. LOT CLASSIFICATION: If The Quantity Is 1000 PCS Or More, 1000 PCS Is One Lot

2. Sampling Test Method: Mil-std-105e G-ii

3.Test Level

A) High Level Defect : AQL 0.065% [200 Pcs]
B) Medium Level Defect : AQL 0.25% [50 Pcs]

C) Low Level Defect :AQL 0.4% [32 Pcs]

4. Defect Classification:

A) High Level: @No Frequency; @Mixing; @Leak Defect

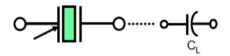
B) Medium Level - Electrical Characteristic Defect:

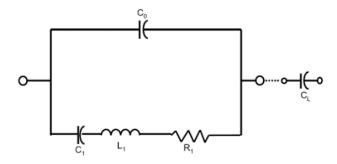
@Frequency; @Oscillation; @Electrical Current; @Other Electrical Characteristics Defect

C) Visual: @Marking; @Welding; @Leads; @Other Visual Defect

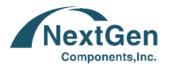
Testing Method And Its Standard Can Be Modified Depending On The Customer's Request

EQUIVALENT CIRCUITS





Symbol for crystal unit



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CHARACTERISTICS

Units and values indicated with { } in this specification are the former units and the specified values.

Standard Atmospheric Conditions:

Unless otherwise specified the standard range of atmospheric conditions for making measurements and tests is as

follows:

Ambient temperature: 15°C to 35°C;

Relative humidity: 25% to 85%;

Air pressure: 86 to 106 k Pa

If there is any doubt about the results measurements shall be made within the following limits:

Ambient temperature : $25\pm1^{\circ}C$;

Relative humidity : 63% to 67%;

Air pressure: 86 to 106 k Pa

Operating Temperature Range:

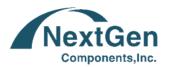
The operating temperature range is the range of ambient temperatures at which the quartz crystal oscillator can be stored without damage. Conditions are as specified elsewhere on these specifications.

Operating temperature range: -40°C to +85°C

Storage Temperature Range:

The storage temperature range is the range of ambient temperatures at which the quartz crystal oscillator can be stored without damage. Conditions are as specified elsewhere on these specifications.

Storage temperature range: -55°C to +125°C



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CAUTION

In Order To Maintain Quality. Without Change In Characteristics Of The crystal Units. Please Follow Below Recommendation

Shock

All Crystal Units Have A Thin Crystal Blanks Within If It Is Dropped Above The Recommended Dropping Height (500mm) The Specific Characteristics And Appearance Can Be Changed Please Pay Special Attention To External Shock

Environmental

- Crystal Units' Frequency Can Be Changed Due To Surrounding Temperature If It Is Stored Next To A High Temperature Heter (Above+85'c) Or Below 40'c.And A Strong Light Source For Long Period Of Time. The Electrical Characteristics Can Be Changed It Is Suggested That These Environment Be Avoided
 If The Unit Is Placed In A Humid Environment. Lead Terminal Can Be Damaged: Therefore. Do Not Store The Crystal Units In A Humid Environment
- 3) Crystal unit Has Vibrating Characteristics If It Is Placed Where Vibration Exists The Operating Characteristics Can Be Altered: Therefore This Environment Should Be Avoided

Leads

1) After Soldering Crystal Units Into A PCB Impacting The Unit From The top, bottom Left Or Right Side Of The Unit Can Shatter The Glass Portion Of The Base Aendering The Unit Useless

Assembly Method

- 1) Correct Ultrasonic Frequency For Cleaning Should Be Less Than 20khz
- 2) SOLDERING SHOULD BE BONE USING IEC 61760-1 OR Pb-free Products

Storage

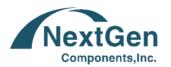
5.5.1 If The Crystal Units Are Stored In Humid Or Salty Environment Appearance Can Be Changed And Solderability Can Deteriorate; Therefore avoid Storing In Such Environment Do Not Store The Crystal Unit More Than 3 Months



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RELIABILITY (MECHANICAL AND ENVIRONMENTAL ENDURANCE)

TEST ITEMS	TEST METHOD AND CONDITIONS	REQUIREMENTS
Vibration	(1) Vibration Frequency: 10 To 55hz	Frequency Change:
	(2) Vibration Amplitude: 1.5mm	±10ppm Max.
	(3) Cycle Time: 1~2min(10-55-10hz)	Resistance Change:
	(4) Direction: X.Y.Z	± 15% RRMax
	(5) Duration: 2h/Each Direction	
	(6) G-force: ≥5g	
SHOCK	3 Times Free Drop From 75cm Height To Hard Wooden	Frequency Change:
	Board Of Thickness More Than 30mm.	±10ppm Max.
		Resistance Change:
		± 15% RRMax.
LEAKAGE	Put Crystal Units Into A Hermetic Container And Helium	Leakage:1x10 ⁻ 8mbar.L/S
	For 0.5-0.6. MPA and Keep It For 1h;check The Leakage	Max.
	By A Helium Leak Detector.	
SOLDERABILITY	(1) Dip The Leads Into Flu X (ROJIN Methanol) For 3~5s.	The Dipped Part Of The
	(2) Dip The Leads Into 245±5°C 99% Sn Dipping Solution	Leads Should Have
	For 5s.	95% SN Coating.
SOLDERING HEAT	(1) Perform Electrical Characteristics Test Before Starting	Should Pass Sealing
RESISISTANCE	This Procedure.	And Visual Test.
TEST	(2) Dip The Leads Into Flux(rojin Methanol) 5±0.5s.	Frequency Change:
	(3) Dip The Leads Into 260±5°C 99% Sn Dipping Solution	±10ppm Max.
	For 5s.	
	(4) Take The Unit Out ,Store At Room Temper For 30s	
	Then Measure The Electrical Characteristics.	
LEAK TEST	Use Helium Leak Detector.	Gas Or Air Should Not
	Bombing Pressure:5kg/Cm ²	Be Detected.
	Bombing Time: 2 Hours	
	Leak Should Be Less Than 1e-8 Atm. Cc/Sec.	



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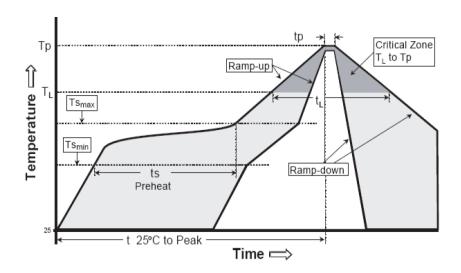
RELIABILITY (MECHANICAL AND ENVIRONMENTAL ENDURANCE)

Test Items	Test Method And Conditions	Requirements
HIGH	The Crystal Units Shall Be Put In	Frequency Change:
TEMPERATURE	Somewhere For 500 Hours At Temperature Of	±10ppm Max.
ENDURANCE	125°C ±5°C ,Then Keep It For 1 To 2 Hours Under	Resistance Change:
	Room Temperature.	± 15%rrmax.
LOW	The Crystal Units Shall Be Put In Somewhere For 500 Hours	Frequency Change:
TEMPERATURE	At Temperature Of -40°C ,Then Keep It For 1 To 2 Hours	±10ppm Max.
ENDURANCE	Under Room.	Resistance Change:
		± 15% RRMax
HUMIDITY	Somewhere At 40°C ±5°C In Relative Humidity Of 90%~95%	Frequency Change:
ENDURANCE	For 72 Hours, Then Keep It For One Or Two Hours Under	±10ppm Max.
	Room Temperature	Resistance Change:
		± 15% RRMax
TEMPERATURE	Temperature Shift From Low(-40°C) To High(100°C,keep 30	Frequency Change:
CYCLE	Minutes),satisfy High(100°C) To Low(-40°C ,Keep 30	±10ppm Max.
	Minutes),then Go Up To Room Temperature For 10 Cycles.	Resistance Change:
		± 15% RRMax
LEAD	(1) Fix The Unit.	Should Pass
TENSILTY	(2) Apply 2lb Of Weight Axis To The Leads.	Sealing And Visual
	(3) Time:5s	Test.
LEAD BENDING	(1) Attach 1lb Of Weight To Each Of The Leads.	Should Pass
	(2) Bending Angle:90°(from The Nomal Position To	Sealing And Visual
	45°oppostte Direction)	Test.
	(3) Bending Time:3s(each Direction) Number Of	
	Bending:2times	
	(4) Number Of Bending:2times	
MARKING	Submerge The Unit Into Ipa [isopropyl Alcohol] Solution For	Marking Should Not
ERASE	10minutes And Brush The Marking 10 Times With A Tooth	Be Erased.
	Brush.	

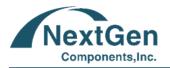
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SUGGESTED REFLOW PROFILE (For Reference Only)

Total time: 200 Sec. Max. Solder melting point: 220°C



Profile Feature		Pb-Free Assembly
Average Ramp-up Rate (Ts Max to Tp)		3°C/second Max
Preheat Temperature Min (Ts Min.) Temperature Max (Ts Max.) Time (ts Min. to ts Max.)		125℃
		200°C
		60 ~ 180 seconds
Time maintained	Temperature (TL)	217°C
above	Time (tı)	60 ~ 150 seconds
Peak/Classification	Temperature (Tp)	260 ℃
Time within 5°C of	actual Peak Temperature (tp)	20 ~ 40 seconds
Ramp-down rate		6 °C /Second Max.
Time 25 °C to Peak	Temperature	8 minutes Max.
Suggest reflow time	es	3 Times Max.



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MATERIAL DATA DECLARATION SHEET

Component	Material	Material		Substances			
	Name	Mass (mg)	Name	Symbol	CAS#	Weight (mg)	Analysis (%)
		6.112	Nickel	Ni	7440-02-0	2.506	41.00%
			Iron	Fe	439-89-6	3.534	57.82%
	Metal Ring		Cobalt	Со	7440-48-4	0.031	0.51%
	(42Ni)		Manganese	Mn	7439-96-5	0.024	0.40%
			Silicon	Si	7440-21-3	0.01	0.16%
			Carbon	С	7440-44-0	0.006	0.10%
			Silicon dioxide	SiO2	7631-86-9	1.696	61.68%
		2.750	Aluminum oxide	AI2O3	1344-28-1	0.242	8.81%
	Glass		Boron oxide	B2O3	1303-86-2	0.448	16.30%
Base			Lithium oxide	Li2O	12057-24-8	0.061	2.20%
base			Sodium oxide	Na2O	1313-59-3	0.242	8.81%
			kalium oxide	K2O	12030-88-5	0.061	2.20%
	Leads (Kovar)	3.521	Iron	Fe	7439-89-6	1.889	53.64%
			Nickel	Ni	7440-02-0	1.021	29.00%
			Cobalt	Со	7440-48-4	0.598	16.98%
			Carbon	С	7440-44-0	0.001	0.02%
			Silicon	Si	7440-21-3	0.009	0.26%
			Manganese	Mn	7439-96-5	0.003	0.09%
		2.586	plumbum	Pb	7439-92-1	2.338	90.41%
	Surface Coating	٠	Tin	Sn	7440-31-5	0.248	9.59%
		0.045	Copper	Cu	7440-50-8	0.045	1.74%
			Copper	Cu	7440-50-8	23.018	74.98%
			Nickel	Ni	7440-02-0	3.713	12.10%
Ca	Metal Case	30.700	Zinc	Zn	7440-66-6	3.938	12.83%
Cover			Manganese	Mn	7439-96-5	0.028	0.09%
			Iron	Fe	7439-89-6	0.002	0.01%
	Surface Coating	4.999	Nickel	Ni	7440-02-0	4.999	100.00%



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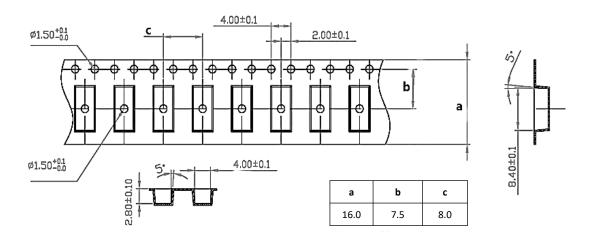
MATERIAL DATA DECLARATION SHEET

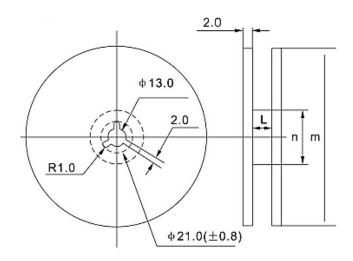
Component	Material	Material		Substances			Material	
	Name	Mass (mg)	Name	Symbol	CAS#	Weight (mg)	Analysis (%)	
Quartz (BlanK)	Quartz Blank	2.361	Silica	SiO2	14808-60-7	2.361	100.00%	
			Chromium	Cr	7440-47-3	0.002	5.26%	
Blank	Blank	0.038	Tin	Sn	7440-31-5	0.006	15.79%	
Metalization	Metalization		Silver	Ag	7440-22-4	0.03	78.95%	
	Solder (For		plumbum	Pb	7439-92-1	2.57	89.86%	
Solder	Blank	2.860	Silver	Ag	7440-22-4	0.06	2.10%	
	Attachment)		Tin	Sn	7440-31-5	0.23	8.04%	
	Ероху		Quartz	Sio2	14808-60-7	42.095	60.00%	
		70.158	Filler	silicon dioxide	7631-86-9	22.801	32.50%	
Plastic Mold			Phenol- formaldehy de polymer		9003-35-4	3.508	5.00%	
	compound		Boron zinc hydroxide oxide	b12Zn4(OH)1 4O15	138265-88-0	1.403	2.00%	
			Pigment	Carbon black	1333-86-4	0.351	0.50%	
	Metal	12.730	Copper	Cu	7440-50-8	8.402	66.00%	
Lood France	Frame	12./30	Zinc	Zn	7440-66-6	4.328	34.00%	
Lead Frame	Surface	4.004	Tin	Sn	7440-31-5	0.858	85.71%	
	coating	1.001	Copper	Cu	7440-50-8	0.143	14.29%	

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TAPE/REEL (Unit: mm)

All Devices are packed in accordance with EIA standard RS-481-2 and specifications, 3000pcs/Reel





Pieces per reel	φт	Фп	L	Carrier tape size
3000/reel	330 ± 3	80min	17.5	16

DISCLAIMER

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